

Notice of References Cited

Application/Control No.

10/728,529

Applicant(s)/Patent Under

Reexamination

FUNAKI, TOMOYUKI

Examiner

Jinhee J. Lee

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0023633	09-2001	Matsumoto, Shuichi	84/478
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FOREIGN PATENT DOCUMENTS

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